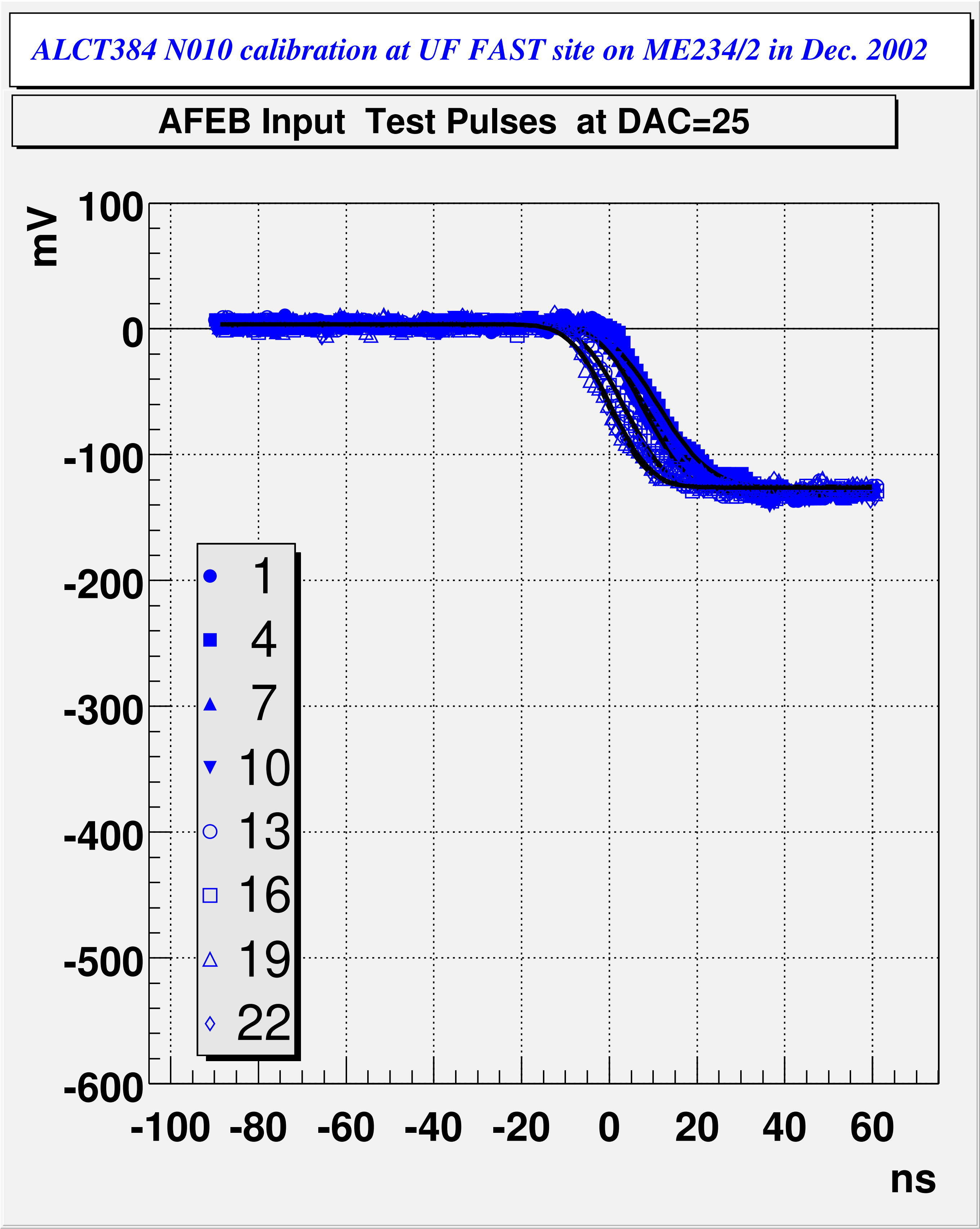
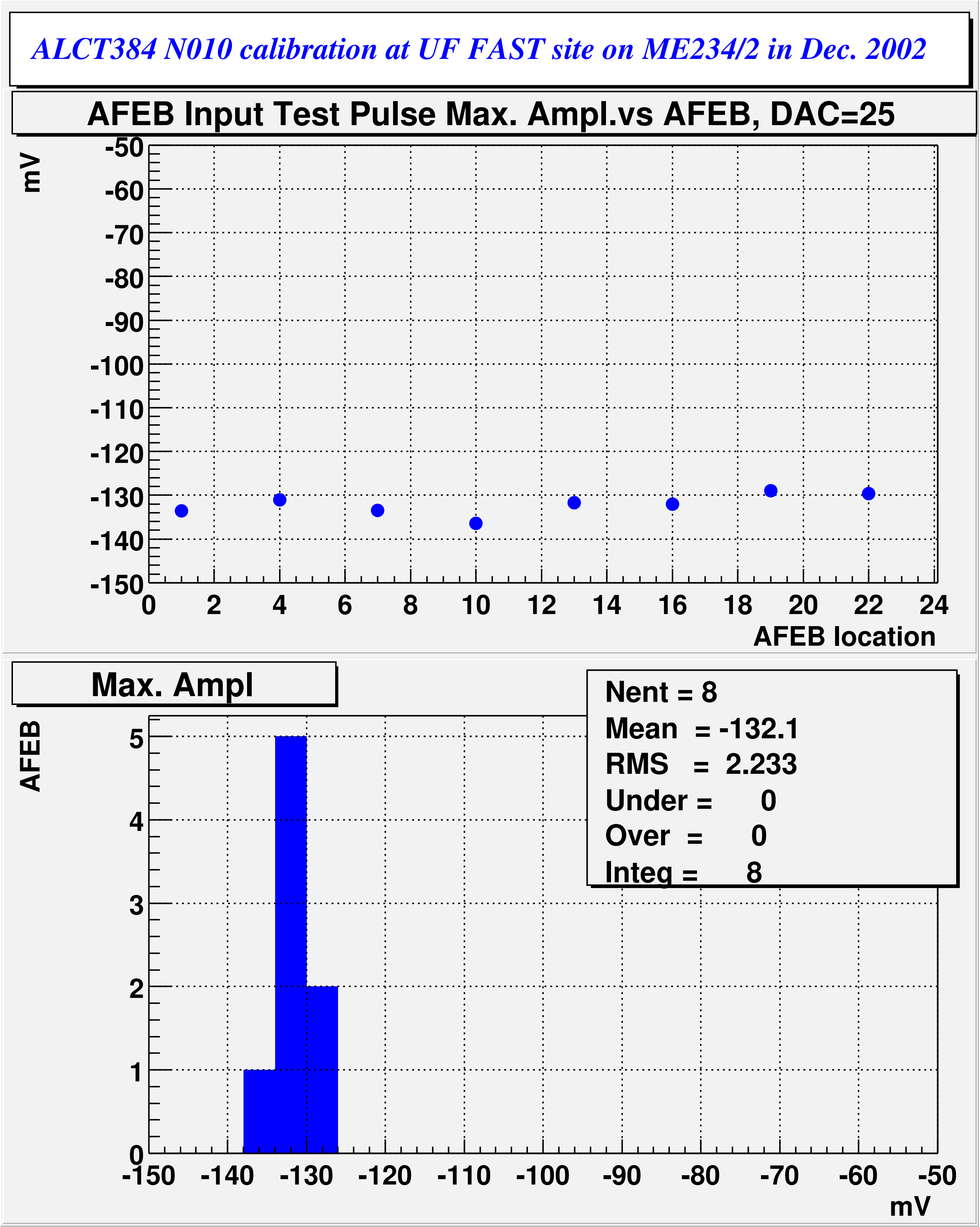

ALCT384 N010 calibration at UF FAST site on ME234/2 in Dec. 2002
AFEB Input Test Pulses at DAC=25
mV
100
0
-100
-200
-300
-400
-500
-600
-100
-80
-60
-40
-20
0
20
40
60
ns
1
4
7
10
13
16
19
22


ALCT384 N010 calibration at UF FAST site on ME234/2 in Dec. 2002
AFEB Input Test Pulse Max. Ampl.vs AFEB, DAC=25
mV
-50
-60
-70
-80
-90
-100
-110
-120
-130
-140
-150
0
2
4
6
8
10
12
14
16
18
20
22
24
AFEB location
Max. Ampl
AFEB
Nent = 8
Mean = -132.1
RMS = 2.233
Under = 0
Over = 0
Integ = 8
0
1
2
3
4
5
-150
-140
-130
-120
-110
-100
-90
-80
-70
-60
-50
mV